Case Docket No. SUGIM38.001AUS

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April 14, 2003

(Date)

Date: April 14, 2003 Page 1

\$0

Filed For

re application of

Tomiichi Hasegawa

pp. No.

09/903,999

July 12, 2001

ANISOTROPY ANALYZING

METHOD AND AN

ANISOTROPY ANALYZING

APPARATUS

Examiner

Thomas R. Artman

Art Unit

2882

FOR THIS AMENDMENT

22202, on

Katsuhiro Arai, Reg. No.

UNITED STATES PATENT AND TRADEMARK OFFICE

P.O. Box 2327

Arlington, VA 22202

Sir:

Transmitted herewith is an amendment in the above-identified application.

The fee has been calculated as shown below:

CLAIMS AS FILED						
	CLAIMS REMAINING AFTER AMENDMENT		HIGHEST NO. PREVIOUSLY PAID FOR	PRESENT EXTRA	RATE	ADDITIONAL FEE
Total Claims	15	_	20	= 0 ×	\$9	= \$0
Independent Claims	3		3	= 0 ×	\$42	= \$0
				TOTAL ADDITIONAL FEE		

- (X) The present application qualifies for small entity status under 37 C.F.R. § 1.27.
- (X) Amendment in nine (9) pages.
- (X) Information Disclosure Statement; PTO-1449 with one (1) reference.
- (X) Return prepaid postcard.
- (X) Please charge any additional fees, including any fees for additional extension of time, or credit overpayment to Deposit Account No. 11-1410.

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SUGIM38.001 AUS PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

plicant : Tomiichi HASEGAWA

09/903,999

Filed : July 12, 2001

Appl. No.

For : AN ANISOTROPY

ANALYZING METHOD AND AN ANISOTROPY ANALYZING APPARATUS

Examiner : T. Artman

AMENDMENT

United States Patent Office and Trademark P.O. Box 2327 Arlington, VA 22202

Dear Sir:

In response to the Office Action mailed January 16, 2003, please amend the above-identified application as follows:

IN THE CLAIMS:

Please amend Claims 1-15 as follows:

1. (Amended) A method for analyzing anisotropy of a sample comprising the steps of:

preparing two light beams having the same wavelength of which the plane of polarization are crossed at a given angle,

introducing the two light beams into a sample to be measured in anisotropy at the same time,

rotating the plane of polarization of one of the two light beams by the given angle so as to correspond to that of the other of the two light beams, after passing the two light beams through the sample,

superimposing the two light beams, and